

**Notice of References Cited**

Application/Control No.

10/767,405

Applicant(s)/Patent Under  
Reexamination  
SHANBHAG ET AL.

Examiner

MICHAEL Y. WON

Art Unit

2155

Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2002/0023184	02-2002	Paul, Harry V.	710/100
*	B	US-2002/0116564	08-2002	Paul et al.	710/301
*	C	US-2003/0076788	04-2003	Grabauskas et al.	370/254
*	D	US-6,608,819	08-2003	Mitchem et al.	370/253
*	E	US-2004/0013125	01-2004	Betker et al.	370/419
*	F	US-2004/0013092	01-2004	Betker et al.	370/254
*	G	US-2004/0081186	04-2004	Warren et al.	370/419
*	H	US-6,763,417	07-2004	Paul et al.	710/316
*	I	US-7,068,651	06-2006	Schmidt et al.	370/389
*	J	US-7,107,347	09-2006	Cohen, Fred	709/229
*	K	US-2008/0028096	01-2008	Henderson et al.	709/236
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
	U					
	V					
	W					
	X					

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
 Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.